June 2006



Features

- Q1: N-Channel
 - 7.0A, 30V $R_{DS(on)} = 0.030\Omega$ @ $V_{GS} = 10V$

 $R_{DS(on)} = 0.044\Omega @ V_{GS} = 4.5V$

- Q2: P-Channel
 - -5A, -30V $R_{DS(on)} = 0.052\Omega$ @ $V_{GS} = -10V$ $R_{DS(on)} = 0.080\Omega$ @ $V_{GS} = -4.5V$
- Fast switching speed
- High power and handling capability in a widely used surface mount package

General Description

These dual N- and P-Channel enhancement mode power field effect transistors are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state ressitance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units |
|------------------|--|-----------|-----|------|-------|
| V _{DSS} | Drain-Source Voltage | | 30 | -30 | V |
| V _{GSS} | Gate-Source Voltage | | ±20 | ±20 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 7 | -5 | А |
| | - Pulsed | | 20 | -20 | |
| P _D | Power Dissipation for Dual Operation | | | 2 | W |
| | Power Dissipation for Single Operation | (Note 1a) | 1 | .6 | |
| | | (Note 1b) | | 1 | |
| | | (Note 1c) | 0 | .9 | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range -55 | | | +150 | °C |
| Thermal C | naracteristics | | | | • |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 7 | 78 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 4 | 10 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|-------------------|-----------|------------|------------|
| FDS8962C | FDS8962C FDS8962C | | 12mm | 2500 units |

Electrical Characteristics $T_A = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|--|---|---|----------|-----------|----------------|----------------|-------|
| Off Charac | cteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | Q1 Q2 | 30 -30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C | Q1 Q2 | | 25 -23 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V _{GS} = 0 V V _{DS} = -24 V, V _{GS} = 0 V | Q1 Q2 | | | 1 -1 | μА |
| I _{GSSF} | Gate-Body Leakage, Forward | V _{GS} = 20 V, V _{DS} = 0 V | All | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | V _{GS} = -20 V, V _{DS} = 0 V | All | | | -100 | nA |
| On Charac | cteristics (Note 2) | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{DS} = V_{GS}, I_D = -250 \mu A$ | Q1 Q2 | 1 -1 | 1.9 -1.7 | 3 -3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C | Q1 Q2 | | -4.5 4.5 | | mV/°C |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = 10 \text{ V}, I_D = 7 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 7 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$ | Q1 | | 21 29 26 | 30 46 44 | mΩ |
| | | V _{GS} = -10 V, I _D = -5 A V _{GS} = -10 V, I _D = -5 A, T _J = 125°C V _{GS} = -4.5 V, I _D = -4 A | Q2 | | 42 57 65 | 52 78 80 | |
| I _{D(on)} | On-State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$ | Q1 Q2 | 20 -20 | | | А |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 5 \text{ V}, I_{D} = 7 \text{ A}$ $V_{DS} = -5 \text{ V}, I_{D} = -5 \text{ A}$ | Q1 Q2 | | 25 10 | | S |
| Dynamic C | Characteristics | | | | | • | ' |
| C _{iss} | Input Capacitance | Q1 V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz | Q1 Q2 | | 575 528 | | pF |
| C _{oss} | Output Capacitance | Q2 | Q1 Q2 | | 145 132 | | pF |
| C _{rss} | Reverse Transfer Capacitance | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ | Q1 Q2 | | 65 70 | | pF |
| R_{G} | Gate Resistance | V _{GS} = 15 mV, f = 1.0 MHz | Q1 Q2 | | 2.1 6.0 | | Ω |
| Switching | Characteristics (Note 2) | | | | | | |
| t _{d(on)} | Turn-On Delay Time | Q1 V _{DD} = 15 V, I _D = 1 A, | Q1 Q2 | | 8 7 | 16 14 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10V, R_{GEN} = 6 \Omega$ | Q1 Q2 | | 5 13 | 10 24 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2 $V_{DD} = -15 \text{ V}, I_{D} = -1 \text{ A},$ $V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$ | Q1 Q2 | | 23 14 | 37 25 | ns |
| t _f | Turn-Off Fall Time | | Q1 Q2 | | 3 9 | 6 17 | ns |
| Qg | Total Gate Charge | Q1 V _{DS} = 15 V, I _D = 7 A, V _{GS} = 10 V | Q1 Q2 | | 10.7 9.6 | 26 13 | nC |
| Q _{gs} | Gate-Source Charge | Q2 | Q1 Q2 | | 1.7 2.2 | | nC |
| Q _{gd} | Gate-Drain Charge | $V_{DS} = -15 \text{ V}, I_{D} = -5 \text{ A}, V_{GS} = -10 \text{ V}$ | Q1 Q2 | | 2.1 1.7 | | nC |

2

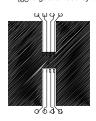
Electrical Characteristics $T_A = 25$ °C unless otherwise noted (Continued)

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units | |
|-----------------|--|---|----------|-----|---------------|-------------|-------|--|
| Drain-Sou | Drain-Source Diode Characteristics and Maximum Ratings | | | | | | | |
| Is | Maximum Continuous Drain-Source Diode Forward Current | | Q1 Q2 | | | 1.3 -1.3 | А | |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = -1.3 \text{ A}$ (Note 2) | Q1 Q2 | | 0.75 -0.88 | 1.2 -1.2 | V | |
| t _{rr} | Diode Reverse Recovery Time | Q1 I _F = 7 A, d _{iF} /d _t = 100 A/µs | Q1 Q2 | | 19 19 | | nS | |
| Q _{rr} | Diode Reverse Recovery Charge | Q2 $I_F = -5 \text{ A}, d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$ | Q1 Q2 | | 9 6 | | nC | |

Notes:

Notes:

1. R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 78°/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125°/W when mounted on a .02 in² pad of 2 oz copper



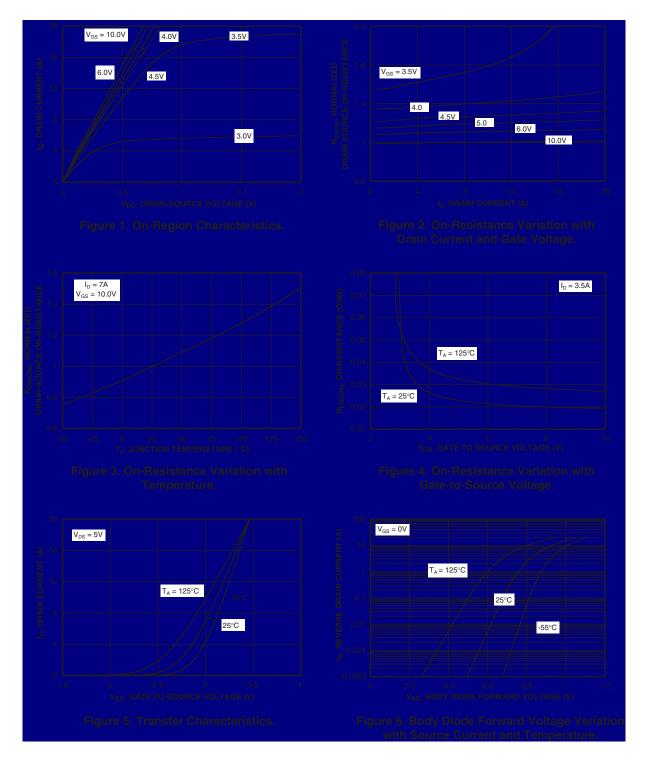
c) 135°/W when mounted on a minimum pad.



Scale 1:1 on letter size paper

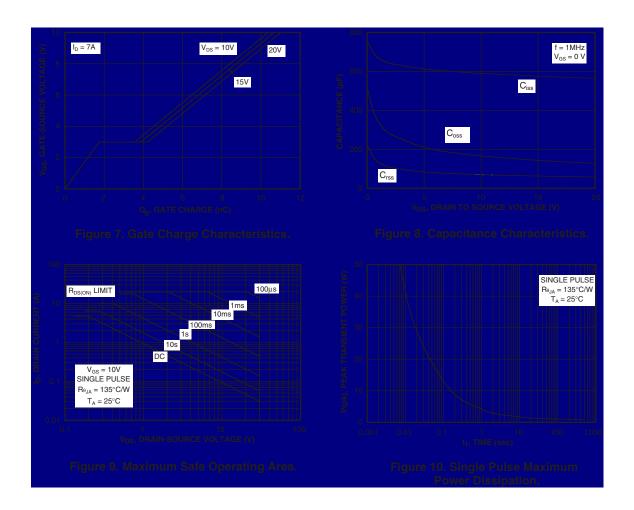
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

Typical Characteristics: Q1 (N-Channel)

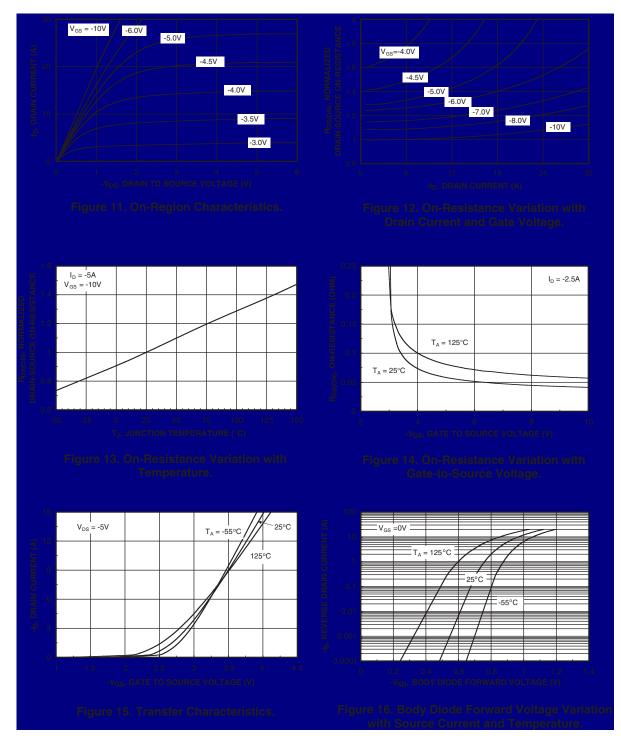


4

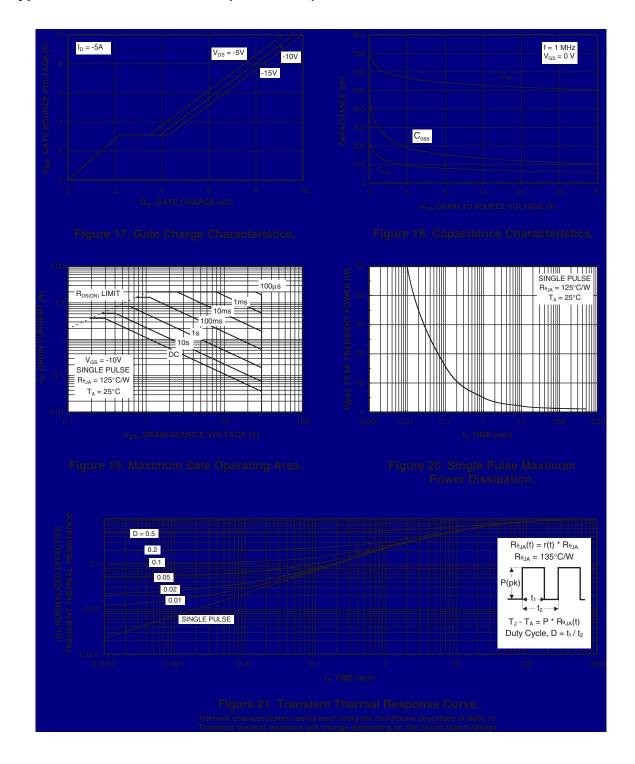
Typical Characteristics: Q1 (N-Channel)



Typical Characteristics: Q2 (P-Channel)



Typical Characteristics: Q2 (P-Channel)



TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

| ACEx™ | FAST [®] | ISOPLANAR™ | PowerEdge™ | SuperFET™ |
|----------------------|---------------------|------------------------|--------------------------|------------------------|
| ActiveArray™ | FASTr™ | LittleFET™ | PowerSaver™ | SuperSOT™-3 |
| Bottomless™ | FPS™ | MICROCOUPLER™ | PowerTrench [®] | SuperSOT™-6 |
| Build it Now™ | FRFET™ | MicroFET™ | QFET [®] | SuperSOT™-8 |
| CoolFET™ | GlobalOptoisolator™ | MicroPak™ | QS™ | SyncFET™ |
| $CROSSVOLT^{TM}$ | GTO™ | MICROWIRE™ | QT Optoelectronics™ | TCM™ |
| DOME™ | HiSeC™ | MSX™ | Quiet Series™ | TinyLogic [®] |
| EcoSPARK™ | I ² C™ | MSXPro™ | RapidConfigure™ | TINYOPTO™ |
| E ² CMOS™ | i-Lo™ | OCX™ | RapidConnect™ | TruTranslation™ |
| EnSigna™ | ImpliedDisconnect™ | OCXPro™ | SerDes™ | UHC™ |
| FACT™ | IntelliMAX™ | OPTOLOGIC [®] | ScalarPump™ | UniFET™ |
| FACT Quiet Series | тм | OPTOPLANAR™ | SILENT SWITCHER® | UltraFET [®] |
| Across the board. A | Around the world.™ | PACMAN™ | SMART START™ | VCX™ |
| The Power Franchise® | | POP™ | SPM™ | Wire™ |
| Programmable Acti | ve Droop™ | Power247™ | Stealth™ | |

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS Definition of Terms

| Datasheet Identification | Product Status | Definition |
|--------------------------|---------------------------|---|
| Advance Information | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| Obsolete | Not In Production | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only. |